

Enhancement Mode N-Channel Power MOSFET

 $TO-252/NMOS/30V/\pm20V/1.5V/100A/3.5m\Omega$

Rev_{0.5}





30V, $3.5m\Omega$, 100A, Single N-Channel

1.Features

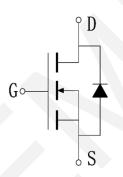
- ◆ 30V MOSFET technology
- ◆ Low on-state resistance
- ◆ Fast switching
- ♦ Vgs±20V

2.Appl	ications
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- ◆ Power Switching Application
- Load Switching



V _{DS}	R _{DS(on)} Typ.	I _D Max.
201/	3.5mΩ @ 10V	1004
30V	4.9mΩ @ 4.5V	100A



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP30100KA	WP30100KA	TO-252	2,500	25,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V _{DSS}	30	V
Gate to Source Voltage	V _{GSS}	±20	V
Drain Current (DC)	ID	100	А
Drain Current (Pulse), PW≤300μs	I _{DP}	360	А
Total Dissipation	P _D	65	W
Avalanche Energy, Single Pulsed	Eas	196	mJ
Junction Temperature	Tj	150	°C
Storage Temperature	T _{stg}	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Junction to case	Rejc	2.3	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

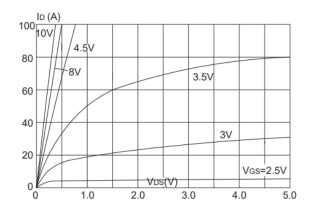
6.Electrical Characteristics at Ta=25°C (Note 3)

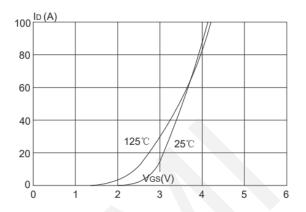
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A$, $V_{GS} = 0 V$	30	-	-	V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = 30V, V _{GS} = 0V			100	nA
Gate to Source Leakage Current	Igss	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _{DS} =250µA	1.0	1.5	2.5	V
Static Drain to Source On-State	Б	I _D = 30A, V _{GS} = 10V	-	3.5	4.2	mΩ
Resistance	R _{DS(on)}	I _D = 20A, V _{GS} = 4.5V	-	4.9	7.5	mΩ
Forward Transconductance	G _{FS}	I _D = 20A, V _{DS} = 5V	20			S
Input Capacitance	Ciss	V _{GS} =0V,		1700		pF
Output Capacitance	Coss	V _{DS} =15V,		320		pF
Reverse Transfer Capacitance	Crss	Frequency=1.0MHz		300		pF
Turn-ON Delay Time	t _{d(on)}			21		ns
Rise Time	tr	$V_{DS} = 15V, I_{D} = 30A,$		32		ns
Turn-OFF Delay Time	t _{d(off)}	$V_{GS} = 10V$, $R_G = 3\Omega$		60		ns
Fall Time	t _f			34		ns
	Qg	V _{DS} = 15V, V _{GS} = 10V,		45		nC
Total Gate Charge	Qgs			3		nC
	Q_{gd}	I _D = 30A		15		nC
Diode Forward Voltage	V _{FSD}	I _S = 30A, V _{GS} = 0	0.5	0.85	1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

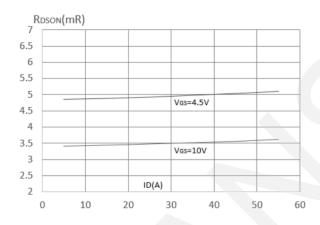


7. Typical electrical and thermal characteristics

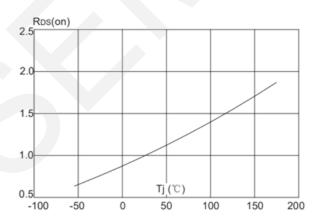




Output Characteristics

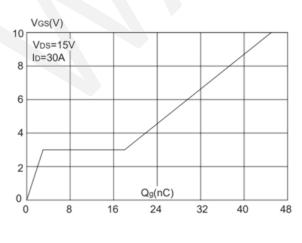


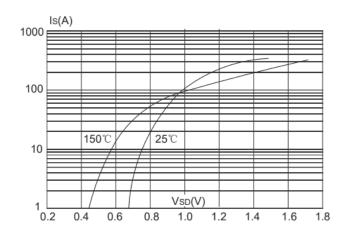
Transfer Characteristics



Rdson-Drain Current

Rdson-Junction Temperature

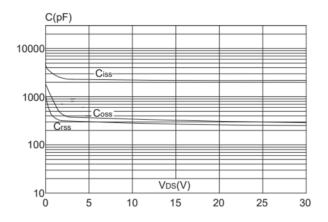


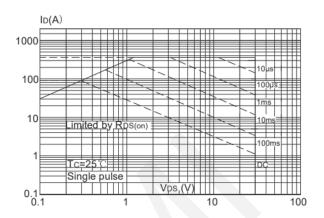


Gate Charge

Source-Drain Diode Forward

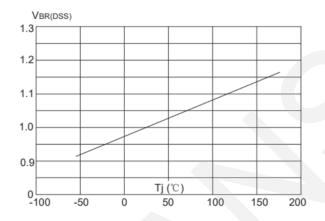


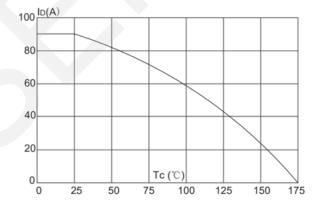




Capacitance vs Vds

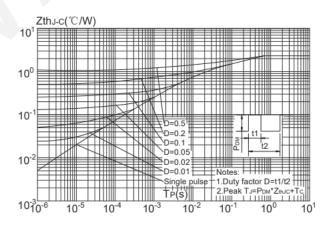
Safe Operation Area





BV_{DSS} vs Junction Temperature

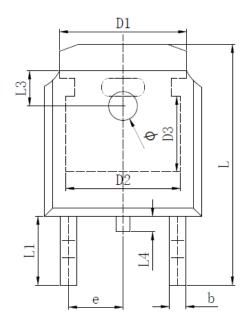
Maximum Continuous Drain Current vs. Case Temperature

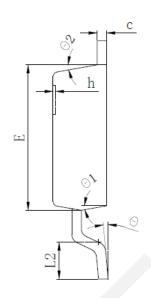


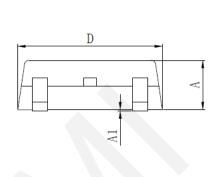
Normalized Maximum Transient Thermal Impedance



8.Package Dimensions







SYMBOL	MILLIMETER			
SIMDOL	MIN	Тур.	MAX	
A	2. 200	2. 300	2. 400	
A1	0.000		0. 127	
b	0.640	0.690	0.740	
c(电镀后)	0.460	0. 520	0. 580	
D	6. 500	6. 600	6. 700	
D1		5.334 REF		
D2		4.826 REF		
D3	3.166 REF			
E	6. 000	6. 100	6. 200	
е	2.286 TYP			
h	0.000	0. 100	0. 200	
L	9. 900	10. 100	10. 300	
L1	2.888 REF			
L2	1. 400	1. 550	1. 700	
L3	1.600 REF			
L4	0.600	0.800	1.000	
ф	1. 100	1. 200	1. 300	
θ	0°		8°	
θ 1	9° TYP			
θ2	9° TYP			



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